

Notice of References Cited

Application/Control No.

10/777,750

Applicant(s)/Patent Under
Reexamination
WATANABE, MIKIO

Examiner

Vincent Rudolph

Art Unit

2625

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0111493	06-2004	Yamaguchi et al.	709/219
*	B	US-2003/0053124	03-2003	Iijima et al.	358/1.15
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

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